

# **CRYSTAL SPECIFICATION**



Customer	:	
Customer P/N	:	
Agent	:	
Agent Code	:	
SIWARD P/N	:	XTL571150-W52-437
Customer Approval :		

# 希華品體科技股份有限公司 SIWARD CRYSTAL TECHNOLOGY CO., LTD.

業務部/ SALE DEPARTMENT 2016/04/06

TEL: (04)25347909

FAX: (04)25327885 / 25337396

Steve Chen

Tom Tang

JoJo Lin Approved By URL HTTP://www.siward.com.tw

品質保證部/ QUALITY ASSURANCE DEPT.

TEL: (04)25347909 EXT 1340/1341 Checked By

研發部/R & D DEPT.

TEL: (04)25347909 EXT 1521 Designer

Address:1-1,LANE 111,JUNG-SHAN RD.,SEC.3, TANTZU HSING,TAICHUNG 427,TAIWAN,R.O.C.



lev.	Description of Revision History	Date	Designer	Checked B
1	New Publication	2012/06/04	Jo.Jo Lin	Tom Tang
		1	l .	

# **CRYSTAL SPECIFICATION**

1. Description : Quartz Crystal

2. Nominal Frequency : 12.000000 MHz

3. Center Frequency : 12.000000 MHz

4. Dimension & Drawing No. : SX-3225 ; SXD-00306

5. Oscillation Mode : Fundamental

6. Cutting Mode : AT cut

7. Packing Style : TP-094

8. Measurement Instrument : S&A 250B(Measured FL)

9. Electrical Characteristics

[1] Operating Conditions:

Item	Symbol	MIN.	TYP.	MAX.	Unit	Condition
Operating Temperature Range	Topt	-40		85	$^{\circ}\!\mathbb{C}$	
Storage Temperature Range	Tstg	-40		90	$^{\circ}\mathbb{C}$	
Load Capacitance	CL		18		pF	
Drive Level	DL			100	μW	

# [2] Frequency Stability:

Item	Symbol	MIN.	TYP.	MAX.	Unit	Condition
Tolerance	dF/Fo	-10		10	ppm	Refer to Center Frequency @25±3°C
Stability Over Temperature	dF/F25	-15		15	ppm	Refer to Operating Temperature
Aging	dF/F25	-2		2	ppm	Per Year

dF/Fo: Frequency Deviation Refer to Center Frequency dF/F25: Frequency Deviation Refer to 25  $^{\circ}$ C Frequency



# [3] Electrical Performance:

Item	Symbol	MIN.	TYP.	MAX.	Unit	Condition
Equivalent Series Resistance	ESR			100	Ω	@Series
Shunt Capacitance	C0			5	pF	
Insulation Resistance	IR	500			ΜΩ	@DC 100 Volt

10. Marking: Laser

MONTH: 1 2 3 4 5 6 7 8 9 10 11 12 CODE : A B C D E F G H J K L M

12.0 S DC

### 11. Remark:

*Compliant with RoHS and Siward QAD-S-116 Standard.	

### ■Note

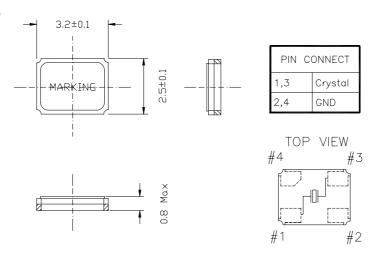
1.General cleaning solutions or ultrasonic cleaning method may be used to clean our products. However, under certain circumstances, ultrasonic cleaning machine could generate resonance at the oscillaton frequency of our products and thus deteriorate the electrical characteristics in devices, and even damage the overall structure of devices. Therefore, verification test is recommended before cleaning.

2. Avoid mounting and processing by Ultrasonic welding this method has a possibility of an excessive vibration spreading inside the crystal products and becoming the cause of characteristic deterioration and not oscillating.

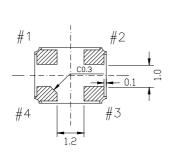


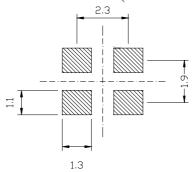
# DIMENSIONS

Unit: mm

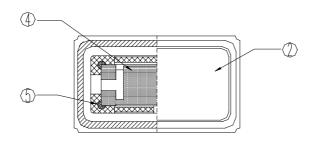


# LAND PATTERN (REFERENCE)





# ■ STRUCTURE ILLUSTRATION





I	PART NAME	MATERIAL	P	PART NAME	MATERIAL
1.	BASE	CERAMIC	4.	ELECTRODE	Metal
2.	LID	KOVAR	5.	ADHESIVES	SILVER GLUE
3.	BLANK	QUARTZ			



# ■ RELIABILITY SPECIFICATION REFER TO JIS C 6701

# 1. ENVIRONMENTAL PERFORMANCE

ITEM	CONDITION
1. HIGH TEMPERATURE	STORED AT 85±2°C FOR 720±12H. ( If Customer's temperature request
STORAGE	is higher than the standard, Temperature test must be done for customer
	requirements.)
	THEN 25±2°C OVER 2H BEFORE TESTING.
2. LOW TEMPERATURE	STORED AT -40±2°C FOR 500±12H. ( If Customer's temperature request
STORAGE	is lower than the standard, Temperature test must be done for customer
	requirements.)
	THEN 25±2°C OVER 2H BEFORE TESTING.
3. HIGH TEMP. & HUMIDITY	STORED AT 60±2℃ AND HUMIDITY 90∼95% FOR 500±12 H.
	THEN 25±2°C OVER 2H BEFORE TESTING.
4. TEMPERATURE CYCLE	THE CRYSTAL UNIT SHALL BE SUBJECTED TO 100 SUCCESSIVE
	CHANGE OF TEMPERATURE CYCLES, THEN 25 ±2℃ OVER 2 H
	BEFORE TESTING, EACH CYCLE AS BELLOW:
	TEMPERATURE DURATION
	140+0/-6°C 30±3 MINUTES
	2. 25°C±2°C 2∼3 MINUTES
	3. $85+4/-0^{\circ}$ C 30 ±3 MINUTES
	4. 25°C±2°C 2∼3 MINUTES

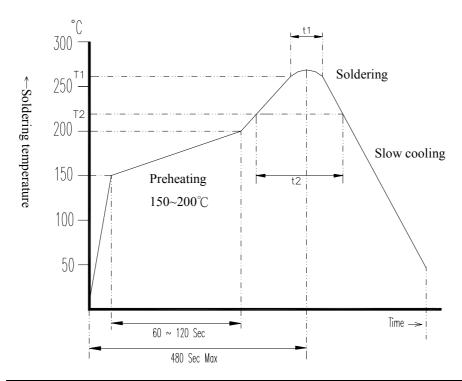
# 2. MECHANICAL PERFORMANCE

ITEM	CONDITION
5. SOLDERABILITY	THE LEAD IS IMMERSED IN A 260±5°C SOLDER BATH WITHIN
	2±0.6 SECONDS.
6. RESISTANCE TO	REFLOW CHART AS ATTACH SHEET. TWICE PASS.
SOLDERING HEAT	
7. FREE FALL	FREE DROPPING FROM 75 cm HEIGHT 3 TIMES ON A HARD
	WOODEN BOARD.
8. VIBRATION	FREQUENCY: 10~55Hz,
	AMPLITUDE (TOTAL EXCURSION): 1.5mm±15%,
	SWEEP TIME: 1MIN, 3 DIRECTION(X, Y, Z) EACH FOR 2 Hrs.
9. GROSS LEAK	STANDARD SAMPLE FOR AUTOMATIC GROSS LEAK DETECTOR,
	TEST PRESSURE: 0.2 Mpa
10. FINE LEAK	HELIUM BOMBING 5.0∼5.5 Kgf / cm <sup>2</sup>
	FOR 2 HOURS.



11. TERMINAL STRENGTH	SHALL BE PRESSURIZED AT A SPEED OF APPROX.0.5mm/sec IN THE DIRECTION INDICATED BY THE ARROW UNTIL THE
	BENDING WIDTH REACHES 3mm AND HELD FOR 5 SECONDS.  PRESSURE ROD R20  R5  SAMPLE  45±2  45±2  R5
12. STICKING TENDENCY	A R0.5 JIG SHALL BE USED TO APPLY A 10N DEAD LOAD IN THE DIRECTION INDICATED BY THE ARROW TO THE ELEMENT AND RETAIN IT FOR 10 SECONDS.  SAMPLE
13. ELEMENT ASSEMBLY	A R0.5 PRESSURIZED BAR SHALL BE USED TO APPLY A 10N
STRENGTH	LOAD IN THE CENTER OF ELEMENT AND RETAIN IT FOR 10 SECONDS.  PRESSUER ROD RO.5 SAMPLE
	L L≥W

# ■ SUGGESTED REFLOW PROFILE

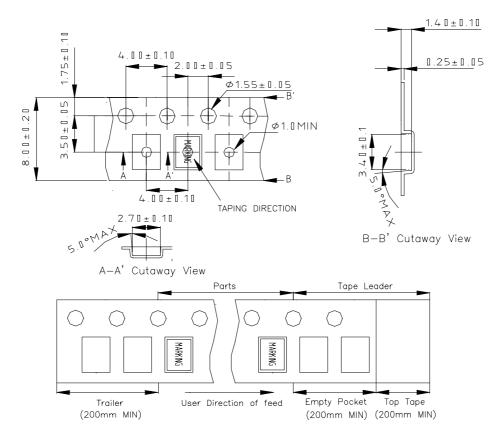


Application\Temperature Time	T1 / t1	T2 / t2
Lead Free	260±5°C / 10±5 Sec Max	217°C Min / 60~150 Sec
Non Lead Free	240±5°C / 10±5 Sec Max	183°C Min / 60~150 Sec

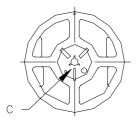


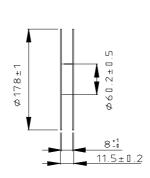
# ■ PACKING Unit: mm

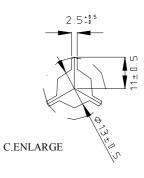
### 1. CARRIER TYPE



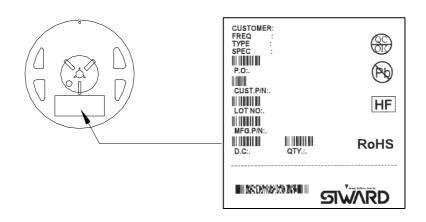
## 2. REEL: 3000 PCS







# 3. LABEL





# Crystal T/C Test Report

Customer Name		
Sustomer Code		
Nominal Frequency	: 12.00000	MHz
Center Frequency	12.00000	MHz

	Cente	r Frequency	Center Frequency: 12.000000 MHz	MHz		Center	r Frequency	Center Frequency: 12.000000 MHz	MHz		Cente	Center Frequency: 12.000000 MHz	: 12.000000	MHz
(G)	@-40°C	೦್ಯ88⊛	J., @	J.,@	No.	@-40°C	@82°C	J., @	), ()	No.	@-40°C	೦್ಯ 58 ಹಿ	J., @	J., @
[ P	[ PPM ]	[ PPM ]	[ PPM ]	[ PPM ]		[ PPM ]	[ PPM ]	[ PPM ]	[ PPM ]		[ PPM ]	[ PPM ]	[ PPM ]	[ PPM ]
۲	-9.24	-11.23												
-	-12.58	-7.75												
7	-12.79	-7.89												
`-	-12.09	-8.60												
`'	-10.63	-9.54												
1	-12.15	-8.29												
'	-11.61	-8.83												
'	-13.20	-7.00												
'	-10.93	-9.81												
1	-11.55	-8.50												
+1	± 15.00	± 15.00			Spec	± 15.00	± 15.00			Sner	± 15.00	± 15.00		
dc	ppm max	ppm max	ррт тах	ppm max		ppm max	ppm max	ppm max ppm max	ppm max	5000	ppm max	ppm max	ppm max	ppm max

Notes:

\*Measure In : S&A 2200A \*Drive Level :  $100\mu W$  \*Load Capacitance : 18.0pF \*Reference Temperature :  $25^{\circ}C$  \*Humidity : 64%

Remark:

SIWARD CRYSTAL TECHNOLOGY CO., LTD.

 $\mathcal{MOL}$ 

Checked By:

9090

Tested By



# **CRYSTAL TEST REPORT**

 Customer name
 :

 Frequency
 : 12.000000
 MHz

 Load Capacitance
 : 18.00
 pF

 Driver Level
 : 100.0
 μW

Date : 2013/04/08 SPEC. NO. : W52-437

NO	FL	RR	C0	C1	DLD2	FDLD	TS	RLD2	SPDB	
NO.	[ppm]	[Ohms]	[pF]	[fF]	[Ohms]	[ppm]	[ppm/pF]		[dB]	
MAX.	10	100	5							
MIN.	-10									
1	-0.50	54.50	0.79	1.543	3.75	1.84	2.18	54.14	-36.86	
2	-1.18	70.41	0.79	1.580	2.38	1.34	2.24	69.57	-37.94	
3	-0.69	68.25	0.80	1.586	2.48	1.33	2.24	67.31	-36.17	
4	-0.09	57.61	0.79	1.622	2.93	1.64	2.30	56.92	-37.61	
5	0.18	57.55	0.80	1.612	2.60	1.61	2.28	56.94	-36.83	
6	0.78	45.80	0.80	1.619	4.46	2.01	2.29	45.81	-40.47	
7	-0.56	56.72	0.79	1.552	3.02	1.74	2.20	56.19	-34.95	
8	-0.84	52.61	0.81	1.581	3.15	1.83	2.23	52.11	-34.27	
9	-1.04	47.66	0.80	1.618	2.86	1.90	2.29	47.28	-35.81	
10	-0.11	52.76	0.79	1.624	3.27	1.81	2.30	52.39	-36.19	
					1		1	1		
MAX	0.78	70.41	0.81	1.624	4.46	2.01	2.30	69.57	-34.27	
MIN	-1.18	45.80	0.79	1.543	2.38	1.33	2.18	45.81	-40.47	
AVG	-0.40	56.39	0.80	1.594	3.09	1.71	2.26	55.87	-36.71	
STD	0.60	7.89	0.01	0.030	0.63	0.23	0.04	7.64	1.73	

NOTES : MEASURE IN S&A 250B	Tested By :	JOJO LIN
MEASURE IN S&A 250B	Checked By:	
		TOM TANG

SIWARD CRYSTAL TECHNOLOGY CO., LTD.